

<b>Notice of References Cited</b>	Application/Control No. 10/790,741	Applicant(s)/Patent Under Reexamination OGAWA, RYUTARO	
	Examiner Sayed T. Zewari	Art Unit 2687	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,223,053	04-2001	Friedmann et al.	455/552.1
*	B	US-6,957,081	10-2005	Leyh et al.	455/553.1
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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